

Optical interferometry – a gentle introduction to the theory

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Motivation

- A – Uninterested: I'm here for the holiday.
- B – Might be interested: I'm sceptical: prove it to me!
- C – Possibly interested: I need to learn more.
- D – Interested: I want to work to understand this.

What we will cover

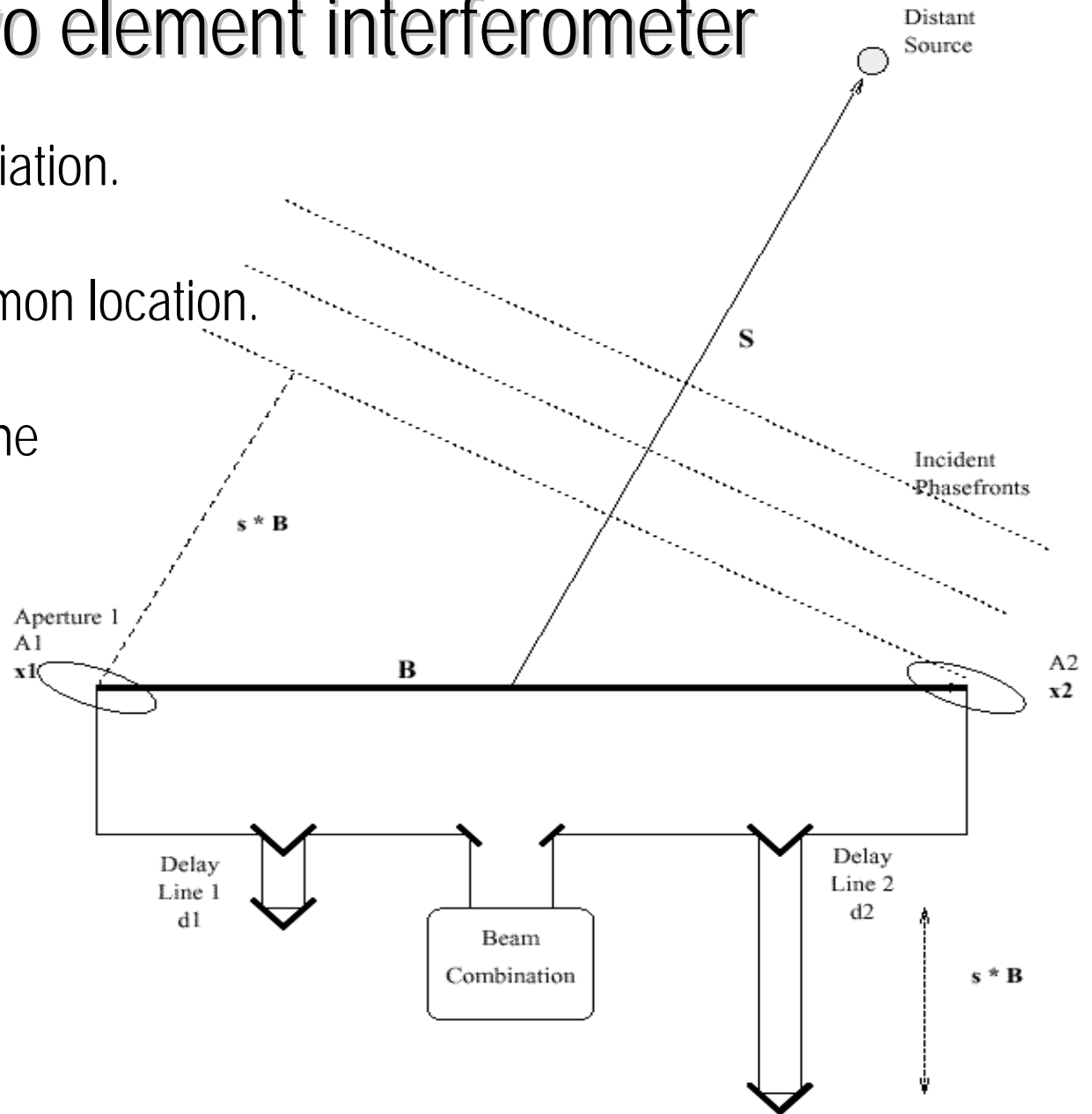
- What no one ever tells you (or admits to).
- What an interferometer does.
- The output of an interferometer.
- How to describe interference fringes.
- What interferometers tell you about sources (qualitative).
- What interferometers tell you about sources (quantitative).
- Visibility functions.
- Imaging with interferometers.

Preamble

- Learning interferometry is like learning to surf:
 - You have to want to do it.
 - You start in the shallows.
 - Having an expensive surf-board doesn't help.
 - You don't have to know how to make surf-boards.
 - Knowing how to surf won't help you escape a charging tiger.
- This is a school:
 - I will assume you know nothing - you should assume the same.
 - Don't guess - physics is not intuitive.
 - Ask questions - last year those who didn't went away confused.
 - If you don't understand ask.
- I am not trying to sell you a surf board:
 - Interferometry is a niche technique - it's not the solution to every astronomical problem.

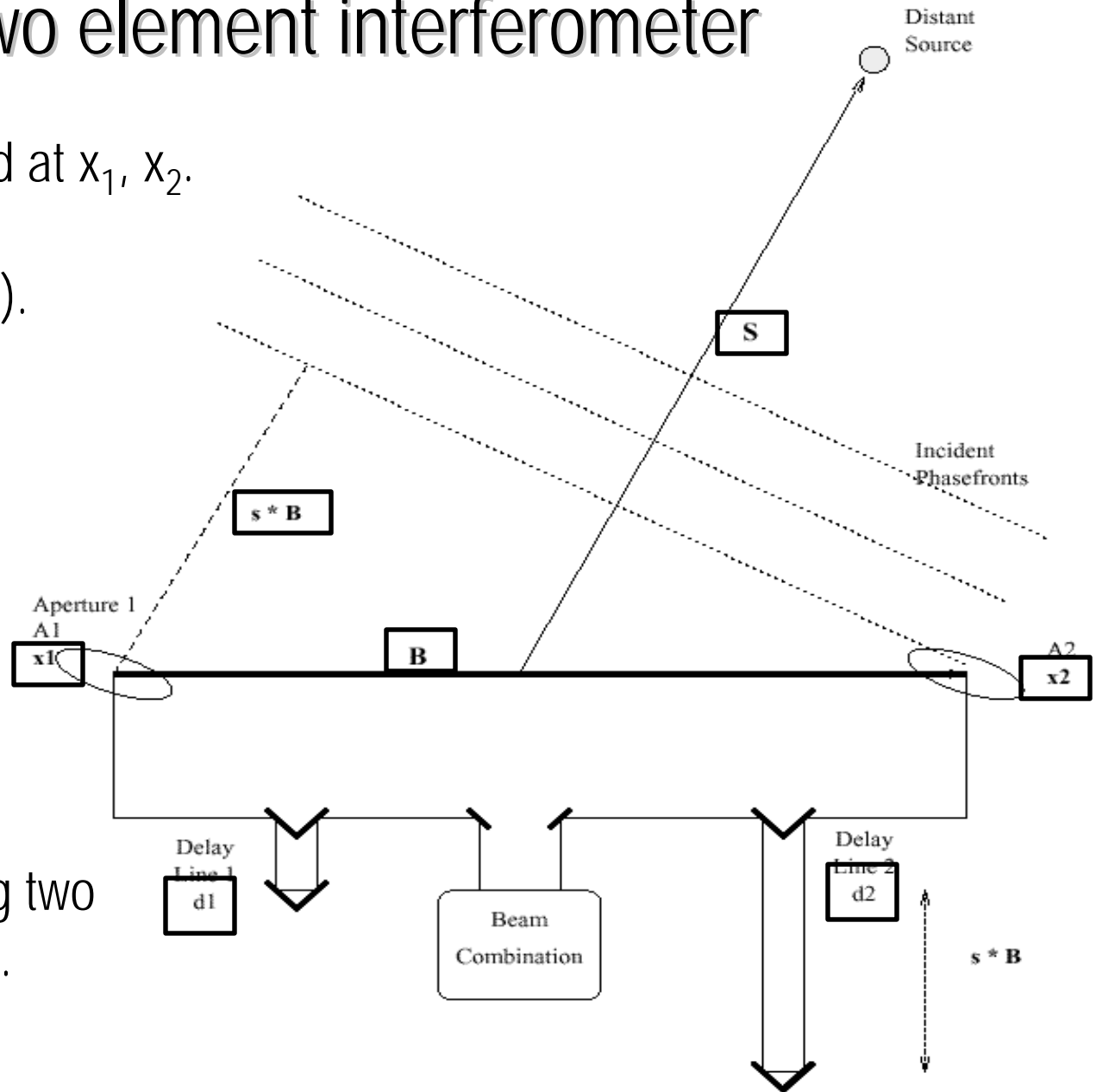
A two element interferometer

- Sampling of the radiation.
- Transport to a common location.
- Compensation for the geometric delay.
- Combination of the beams.
- Detection of the resulting output.



A two element interferometer

- Telescopes located at x_1, x_2 .
- Baseline $B = (x_1 - x_2)$.
- Pointing direction is S .
- Geometric delay is $s \cdot B$, where $s = S/|S|$.
- Optical paths along two arms are d_1 and d_2 .



Key Ideas 1

- Functions of an interferometer:
 - Sampling.
 - Optical path matching.
 - Combination of electric fields.
 - Detection.
- Nomenclature:
 - Baseline.
 - Pointing direction.
 - Geometric delay.

The output of a 2-element interferometer (i)

- At combination the E fields from the two apertures can be described as:
 - $\psi_1 = A \exp (ik[s.B + d_1]) \exp (-i\omega t)$ and $\psi_2 = A \exp (ik[d_2]) \exp (-i\omega t)$
- So, summing these at the detector we get:

$$\Psi = \psi_1 + \psi_2 = A \left[\exp (ik[s.B + d_1]) + \exp (ik[d_2]) \right] \exp (-i\omega t)$$

- And hence the time averaged intensity, $\langle \Psi \Psi^* \rangle$, will be given by:

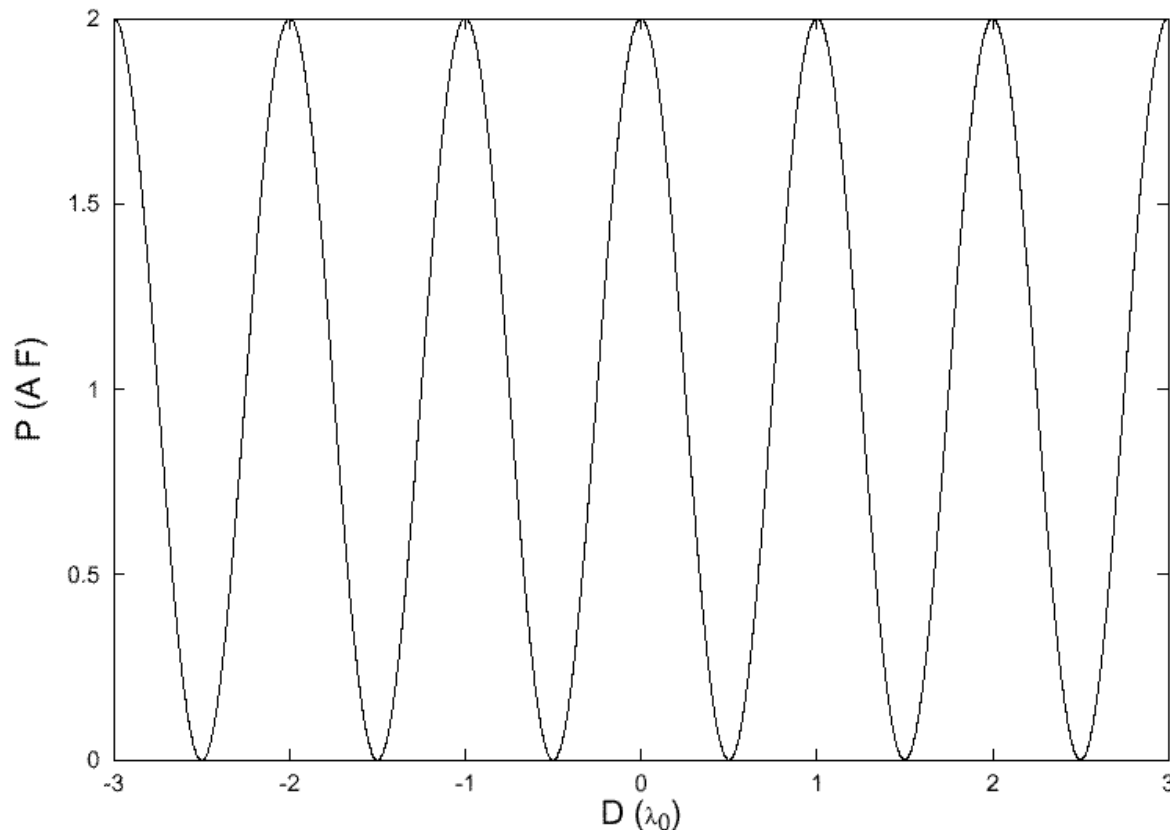
$$\begin{aligned} \langle \Psi \Psi^* \rangle &\propto \langle [\exp (ik[s.B + d_1]) + \exp (ik[d_2])] \times [\exp (-ik[s.B + d_1]) + \exp (-ik[d_2])] \rangle \\ &\propto 2 + 2 \cos (k [s.B + d_1 - d_2]) \\ &\propto 2 + 2 \cos (kD) \end{aligned}$$

Note, here $D = [s.B + d_1 - d_2]$.

This is a function of the path lengths, d_1 and d_2 , the pointing direction and the baseline.

The output of a 2-element interferometer (ii)

$$\begin{aligned} \text{Detected power, } P &= \langle \Psi \Psi^* \rangle \propto 2 + 2 \cos (k [s.B + d_1 - d_2]) \\ &\propto 2 + 2 \cos (kD), \text{ where } D = [s.B + d_1 - d_2] \end{aligned}$$



- The output varies co-sinusoidally with D .
- Adjacent fringe peaks are separated by $\Delta d_{1 \text{ or } 2} = \lambda$ or $\Delta s = \lambda/B$.

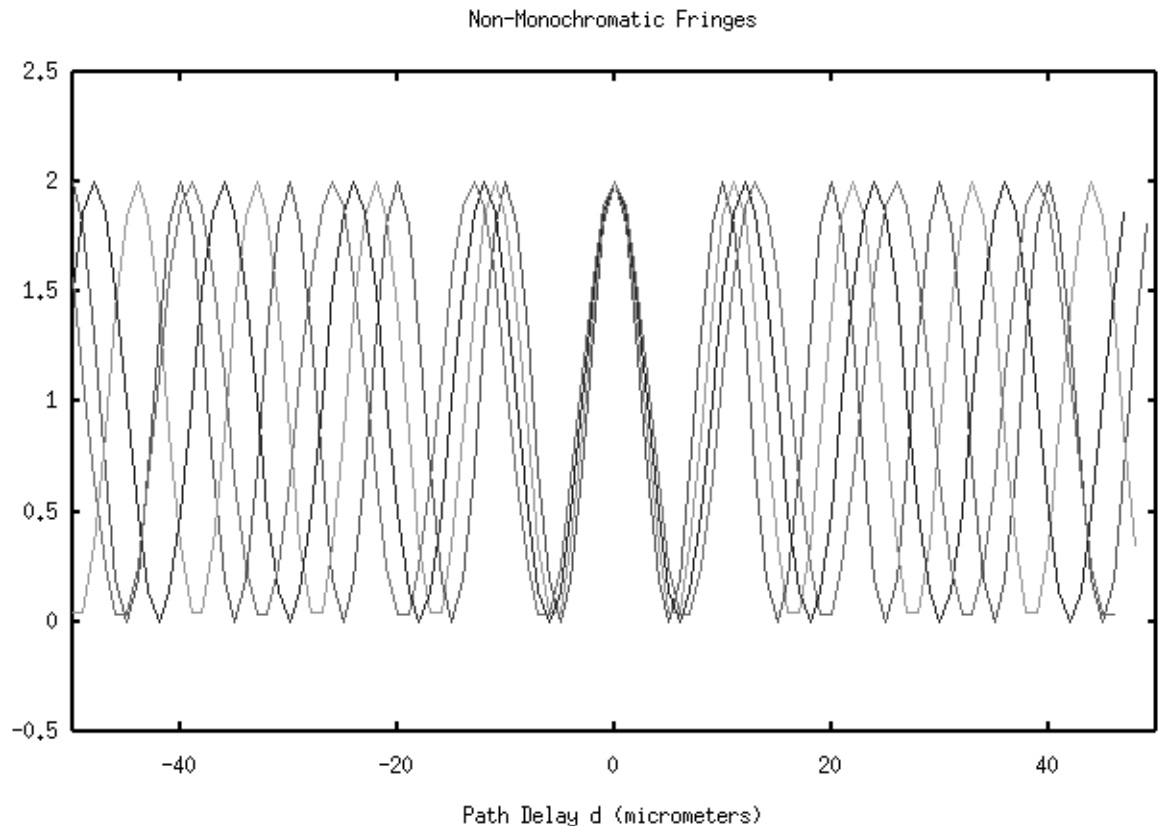
Key ideas 2

- The output of the interferometer is a time averaged intensity.
- It has a cosinusoidal variation - these are the “interference fringes”.
- The cosinusoidal variation is a function of $k \cdot D$, which in turn can depend on many things:
 - The wavevector, $k = 2\pi/\lambda$.
 - The baseline, B .
 - The pointing directions, s .
 - The optical path difference between the two arms of the interferometer, $d_1 - d_2$.
- Note that if you adjust things correctly, the output is fixed. This is what most interferometers actually aim to do.

Extension to polychromatic light

- We can integrate the previous result over a range of wavelengths:
 - E.g for a uniform bandpass of $\lambda_0 \pm \Delta\lambda/2$ (i.e. $\nu_0 \pm \Delta\nu/2$) we obtain

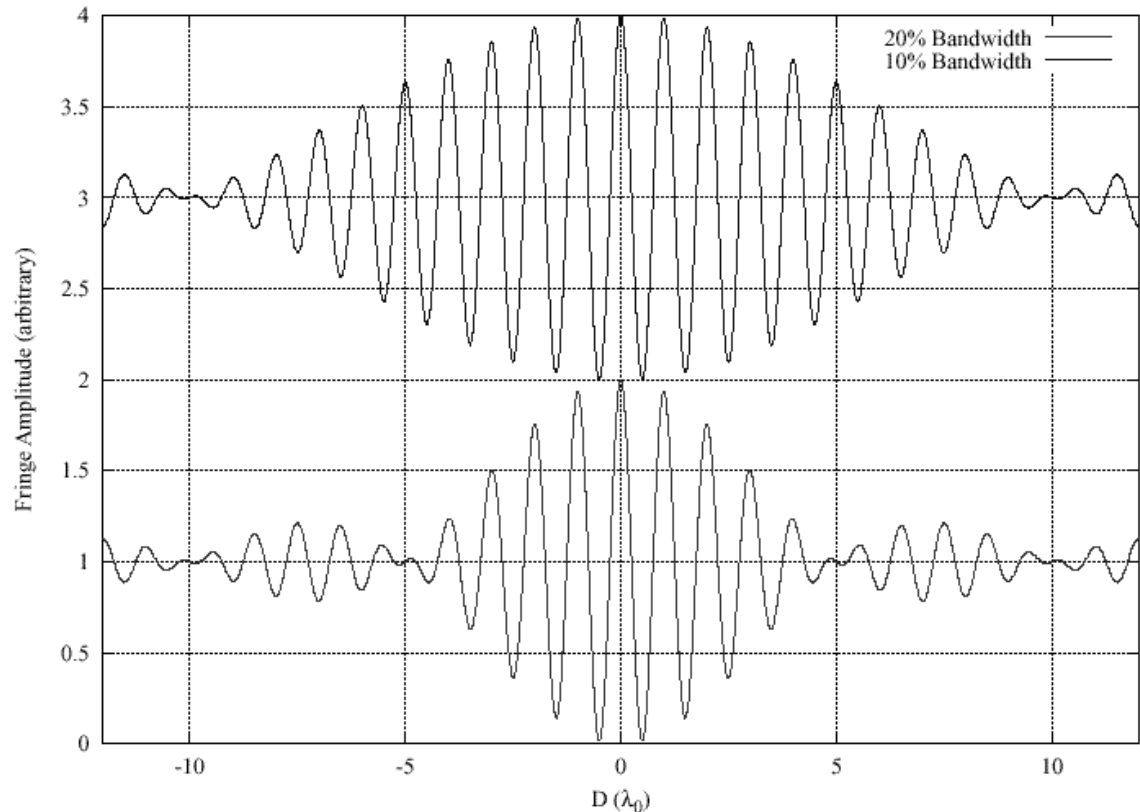
$$P \propto \int_{I_0 - \Delta I / 2}^{I_0 + \Delta I / 2} [2 + 2 \cos(kD)] dI$$
$$= \int_{I_0 - \Delta I / 2}^{I_0 + \Delta I / 2} 2 [1 + \cos(2pD / Ic)] dI$$



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$$\begin{aligned}
 P &\propto \int_{I_0 - \Delta I / 2}^{I_0 + \Delta I / 2} [2 + 2 \cos(kD)] dI \\
 &= \int_{I_0 - \Delta I / 2}^{I_0 + \Delta I / 2} 2 [1 + \cos(2pD / Ic)] dI \\
 &= \Delta I \left[1 + \frac{\sin pD \Delta I / I_0^2}{pD \Delta I / I_0^2} \cos k_0 D \right] \\
 &= \Delta I \left[1 + \frac{\sin pD / \Lambda_{coh}}{pD / \Lambda_{coh}} \cos k_0 D \right]
 \end{aligned}$$



So, the fringes are modulated with an envelope with a characteristic width equal to the coherence length, $\Lambda_{coh} = \lambda_0^2 / \Delta\lambda$.

Key ideas 3

- The response for a polychromatic source is given by integrating the intensity response for each color.
- This alters the interferometric response and can lead to “removal” of the fringe modulation completely:
 - The correct response is only achieved when $k [s.B + d_1 - d_2] = 0$.
 - This is the so called white-light condition.

This is the primary motivation for matching the optical paths in an interferometer and correcting for the geometric delay.

- The narrower the range of wavelengths detected, the smaller is the effect of this modulation:
 - This is usually quantified via the coherence length, $\Lambda_{\text{coh}} = \lambda_0^2 / \Delta\lambda$.
 - But narrower bandpasses mean less light!

Fringe parameters of interest

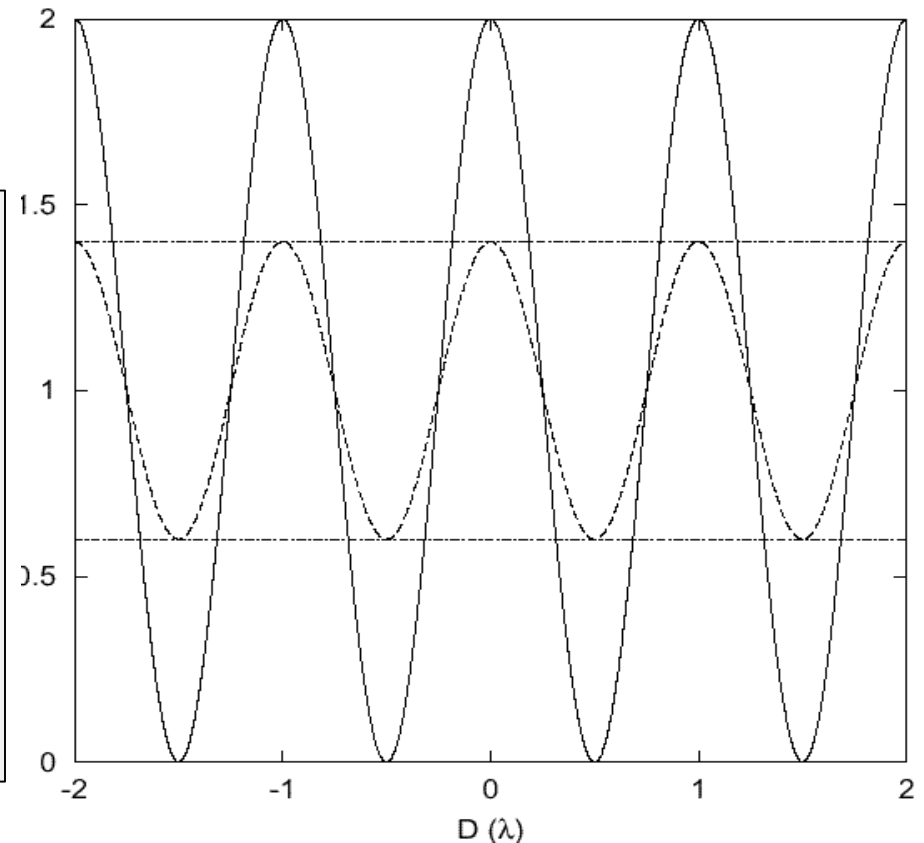
- From an interferometric point of view the key features of any interference fringes are their modulation and their location with respect to some reference point.
- In particular we can identify:

- The fringe visibility:

$$V = \frac{[I_{\max} - I_{\min}]}{[I_{\max} + I_{\min}]}$$

- The fringe phase:

- The location of the white-light fringe as measured from some reference (radians).

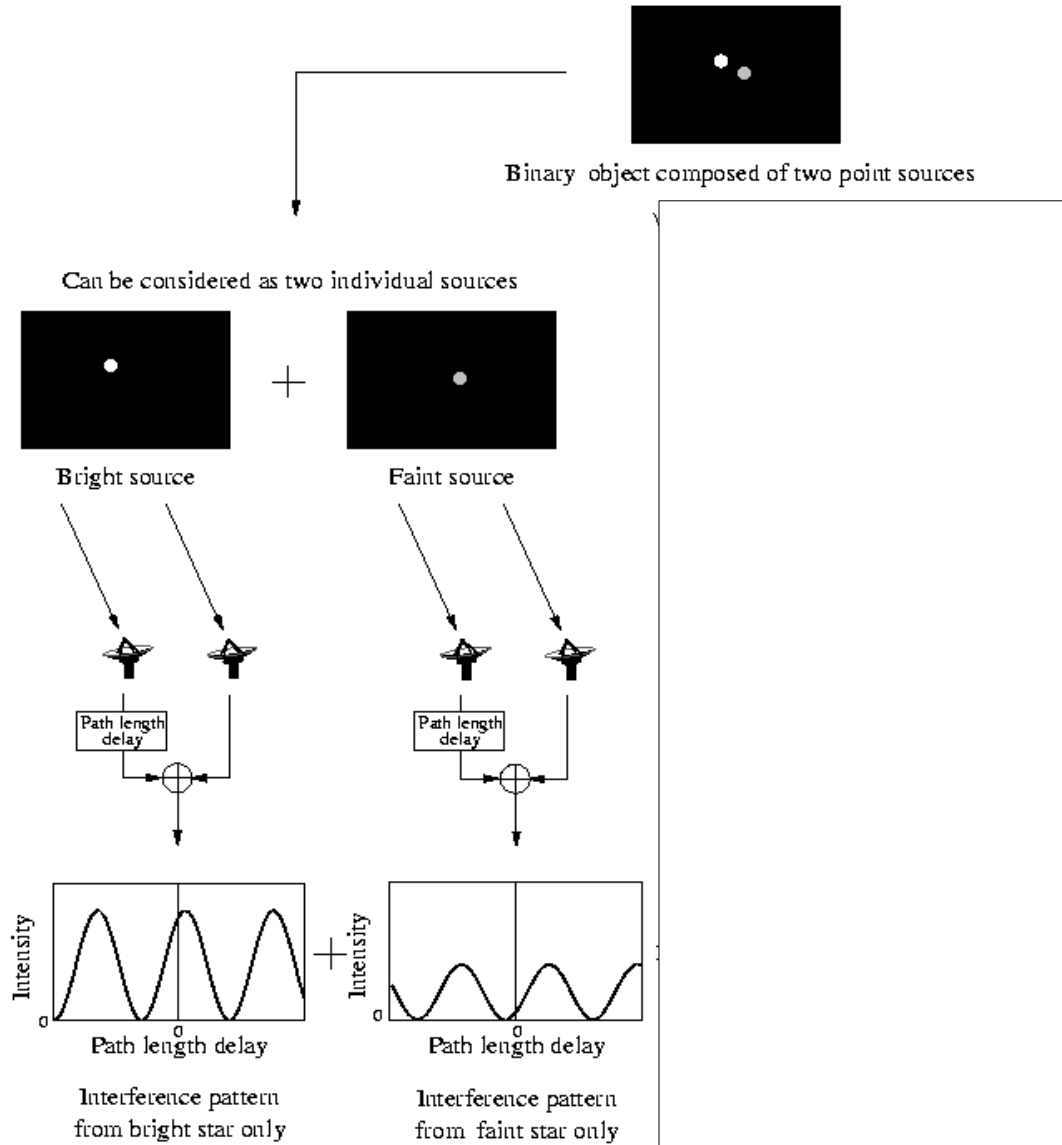


Key ideas 4

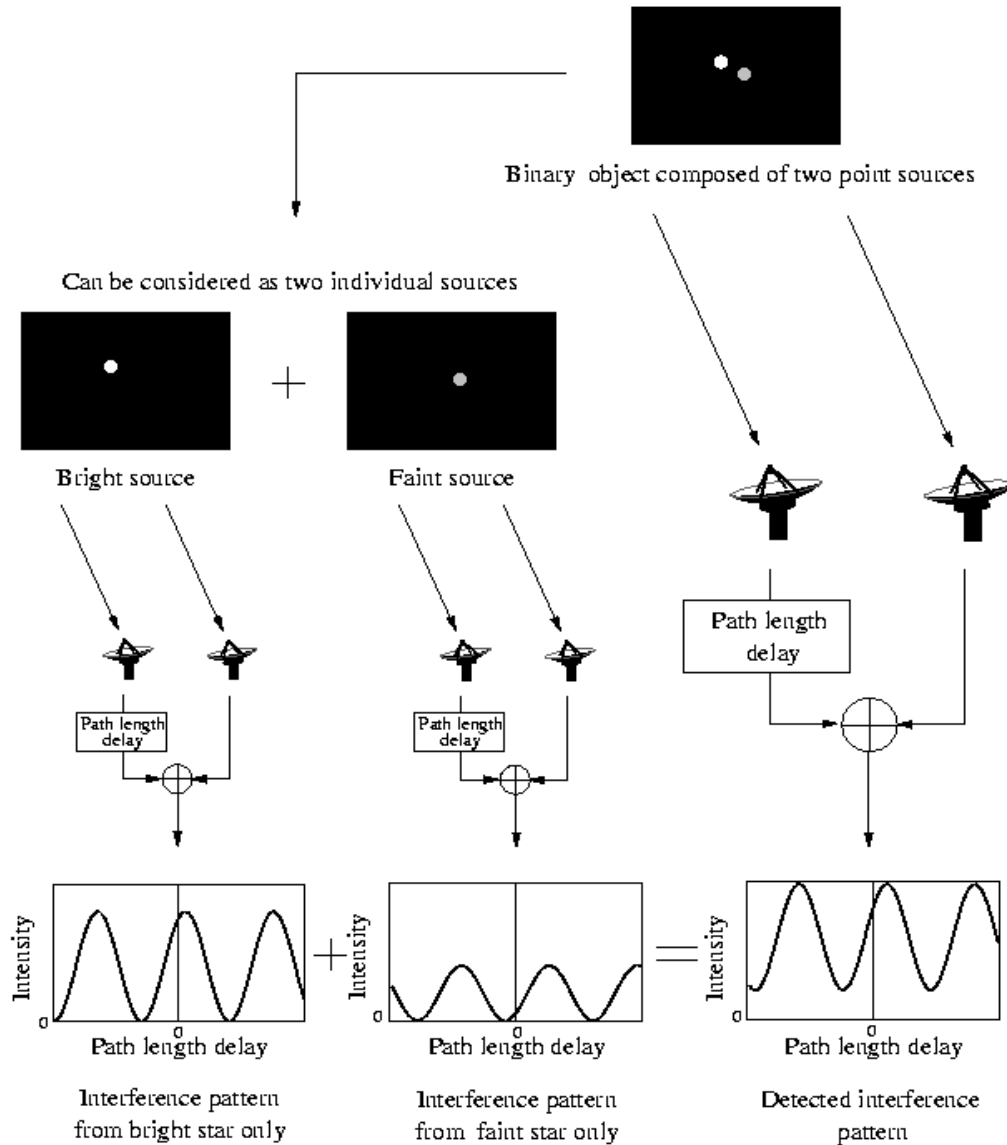
- The parameters of interference fringes that we are usually interested in are:
 - The fringe contrast (excluding any finite bandwidth effects).
 - The fringe phase.
- We are usually not interested in:
 - The fringe period.
- The question you should all be asking now is:
 - Why is it that these are the parameters of interest?
 - And what do they tell us?



Heuristic operation of an interferometer



Heuristic operation of an interferometer



- The resulting fringe pattern has a modulation depth that is reduced with respect to that from each source individually.
- The positions of the sources are encoded in the fringe phase.

Key ideas 5

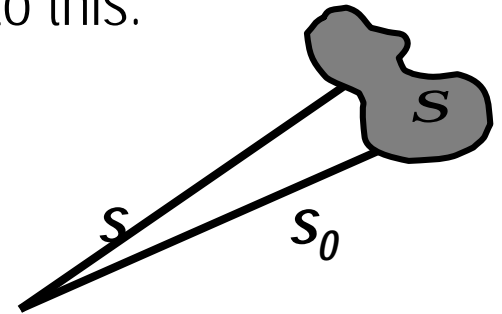
- A general source can be described as a superposition of point sources.
- Each of these produces its own interference pattern.
- The superposition of these is what is actually measured.
 - Technically this is known as the “spatially-incoherent source” approximation.

The modulation and phase of the resulting fringe pattern encode the source structure (albeit in an apparently complicated way).

Response to a distributed source

- Consider looking at an incoherent source whose brightness on the sky is described by $I(s)$. This can be written as $I(s_0 + \Delta s)$, where s_0 is the pointing direction, and Δs is a vector perpendicular to this.
- The detected power will be given by:

$$\begin{aligned}
 P(s_0, B) &\propto \int I(s) [1 + \cos kD] d\Omega \\
 &\propto \int I(s) [1 + \cos k(s \cdot B + d_1 - d_2)] d\Omega \\
 &\propto \int I(s) [1 + \cos k([s_0 + \Delta s] \cdot B + d_1 - d_2)] d\Omega \\
 &\propto \int I(s) [1 + \cos k(s_0 \cdot B + \Delta s \cdot B + d_1 - d_2)] d\Omega \\
 &\propto \int I(\Delta s) [1 + \cos k(\Delta s \cdot B)] d\Omega'
 \end{aligned}$$



The van Cittert-Zernike theorem (i)

- Consider now adding a small phase delay, δ , to one arm of the interferometer. The detected power will become:

$$\begin{aligned} P(s_0, B, \mathbf{d}) &\propto \int I(\Delta s) [1 + \cos k(\Delta s \cdot B + \mathbf{d})] d\Omega' \\ &\propto \int I(\Delta s) d\Omega' + \cos k\mathbf{d} \cdot \int I(\Delta s) \cos k(\Delta s \cdot B) d\Omega' \\ &\quad - \sin k\mathbf{d} \cdot \int I(\Delta s) \sin k(\Delta s \cdot B) d\Omega' \end{aligned}$$

- We now define something called the complex visibility $V(k, B)$:

$$V(k, B) = \int I(\Delta s) \exp[-ik\Delta s \cdot B] d\Omega'$$

so that we can write our interferometer output as:

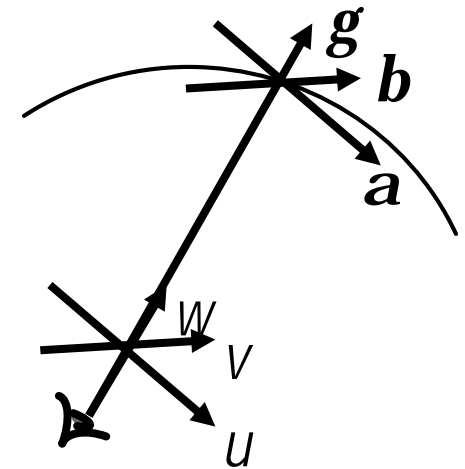
$$P(s_0, B, \mathbf{d}) \propto \int I(\Delta s) d\Omega' + \cos k\mathbf{d} \operatorname{Re}[V] + \sin k\mathbf{d} \operatorname{Im}[V]$$

$$P(s_0, B, \mathbf{d}) = I_{total} + \operatorname{Re} [V \exp[-ik\mathbf{d}]]$$

What is this complex visibility thing?

- Lets assume $s_0 = (0,0,1)$ and Δs is $\approx (\alpha, \beta, 0)$, with α and β small angles measured in radians.

$$\begin{aligned} V(k, B) &= \int I(\Delta s) \exp[-ik\Delta s \cdot B] d\Omega' \\ &= \int I(\mathbf{a}, \mathbf{b}) \exp[-ik(\mathbf{a}B_x + \mathbf{b}B_y)] d\mathbf{a} d\mathbf{b} \\ &= \int I(\mathbf{a}, \mathbf{b}) \exp[-i2\mathbf{p}(\mathbf{a}u + \mathbf{b}v)] d\mathbf{a} d\mathbf{b} \end{aligned}$$



- Here, $u (= B_x/\lambda)$ and $v (= B_y/\lambda)$ are the projections of the baseline onto a plane perpendicular to the pointing direction.
 - These are usually referred to as spatial frequencies and have units of rad^{-1} .

So, the complex visibility is the Fourier Transform of the source brightness distribution.

The van Cittert Zernike theorem (ii)

- We can put this all together as follows:
- Our interferometer measures $P(s_0, B, \mathbf{d}) = I_{total} + \text{Re}[V \exp[-ik\mathbf{d}]]$
- So, if we make measurements with, say, two value of $\delta = 0$ and $\lambda/4$, this recovers the real and imaginary parts of the complex visibility.
- And, since the complex visibility is nothing more than the Fourier transform of the brightness distribution, we have our final result:

The output of an interferometer measures the Fourier transform of the source brightness distribution.

This is the van Cittert-Zernike theorem.

Key ideas 6

- The complex visibility is also known as the “spatial coherence” function.
- Since the FT is a linear transform, if we know the complex visibility we can recover the source brightness distribution.
- Since the visibility function is complex, it has an amplitude and a phase.
- The amplitude and phase of the interference fringes we spoke of earlier, are actually the amplitude and phase of the complex visibility.
- To measure these quantities we have to adjust D .
- A measurement from a single interferometer baseline gives a measurement of one value of the FT of the source brightness distribution.
- Long interferometer baselines measure small structures on the sky, and short baselines, large structures.



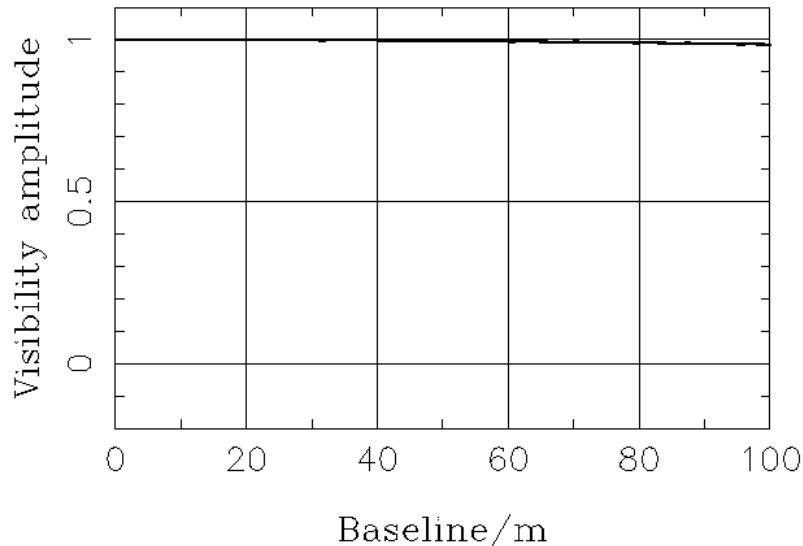
Visibility functions of simple sources (i)

$$V(u) = \int I(\alpha) e^{-i2\pi(u\alpha)} d\alpha / \int I(\alpha) d\alpha$$

- Point source of strength A_1 and located at angle α_1 relative to the optical axis.

$$\begin{aligned} V(u) &= \int A_1 \delta(\alpha - \alpha_1) e^{-i2\pi(u\alpha)} d\alpha / \int A_1 \delta(\alpha - \alpha_1) d\alpha \\ &= e^{-i2\pi(u\alpha_1)} \end{aligned}$$

0.5 mas diameter uniform disk at 2.2 microns



- The visibility amplitude is unity $\forall u$.
- The visibility phase varies linearly with u ($= B/\lambda$).
- Since $|V|$ is close to unity, the interference fringes have high contrast.

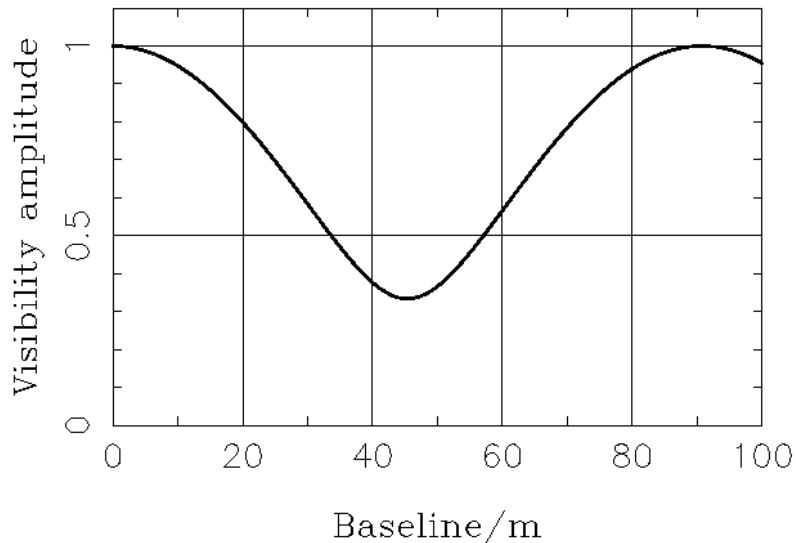
Visibility functions (ii)

$$V(u) = \int I(\alpha) e^{-i2\pi(u\alpha)} d\alpha / \int I(\alpha) d\alpha$$

- A double source comprising point sources of strength A_1 and A_2 located at angles 0 and α_2 relative to the optical axis.

$$\begin{aligned} V(u) &= \int [A_1\delta(\alpha) + A_2\delta(\alpha-\alpha_2)] e^{-i2\pi(u\alpha)} d\alpha / \int [A_1\delta(\alpha) + A_2\delta(\alpha-\alpha_2)] d\alpha \\ &= [A_1 + A_2 e^{-i2\pi(u\alpha_2)}] / [A_1 + A_2] \end{aligned}$$

5 mas binary with 2:1 flux ratio at 2.2 microns



- The visibility amplitude and phase oscillate as functions of u .
- To identify this as a binary, baselines from $0 \rightarrow \lambda/\alpha_2$ are required.
- The modulation of the visibility function tells us the separation and brightness ratio of the components.

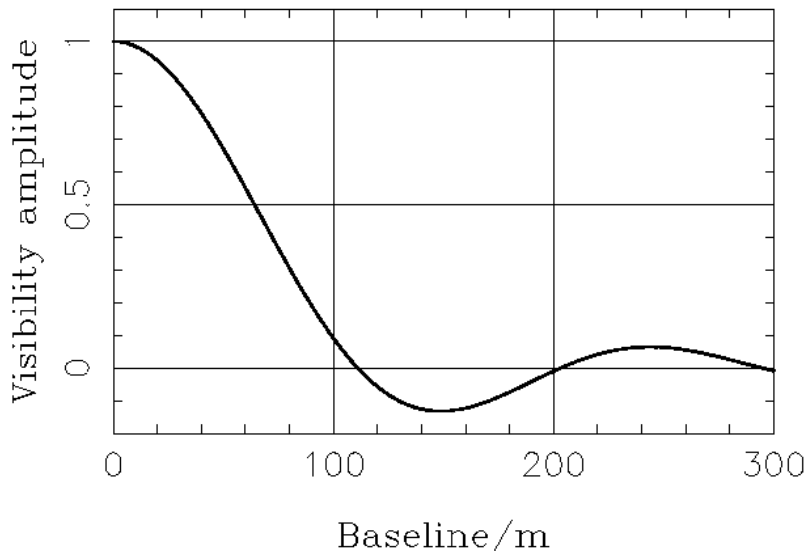
Visibility functions (iii)

$$V(u) = \int I(\alpha) e^{-i2\pi(u\alpha)} d\alpha / \int I(\alpha) d\alpha$$

- A uniform on-axis disc source of diameter θ .

$$\begin{aligned} V(u_r) &\propto \int^{\theta/2} \rho J_0(2\pi\rho u_r) d\rho \\ &= 2J_1(\pi\theta u_r) / (\pi\theta u_r) \end{aligned}$$

5 mas diameter uniform disk at 2.2 microns



- To identify this as a disc requires baselines from $0 \rightarrow \lambda/\theta$ at least.
- The visibility amplitude falls rapidly as u_r increases.
- Information on scales smaller than the disc diameter correspond to values of u_r where $V \ll 1$, where the interference fringes have very low contrast.

Key ideas 7

- Unresolved, sources have visibility functions that remain high, giving produce high contrast fringes for all baseline lengths.
- Resolved sources have visibility functions that fall to low values at long baselines, giving fringes with very low contrast.
=> Fringe parameters for resolved sources will be difficult to measure.
- Imaging with many resolution elements generally needs measurements where the fringe contrast is both high and low (to pick out large scale and small scale features respectively).
- To usefully constrain a source, the visibility function must be measured adequately. Measurements on a single, or small number of, baselines are normally not enough for unambiguous image recovery.

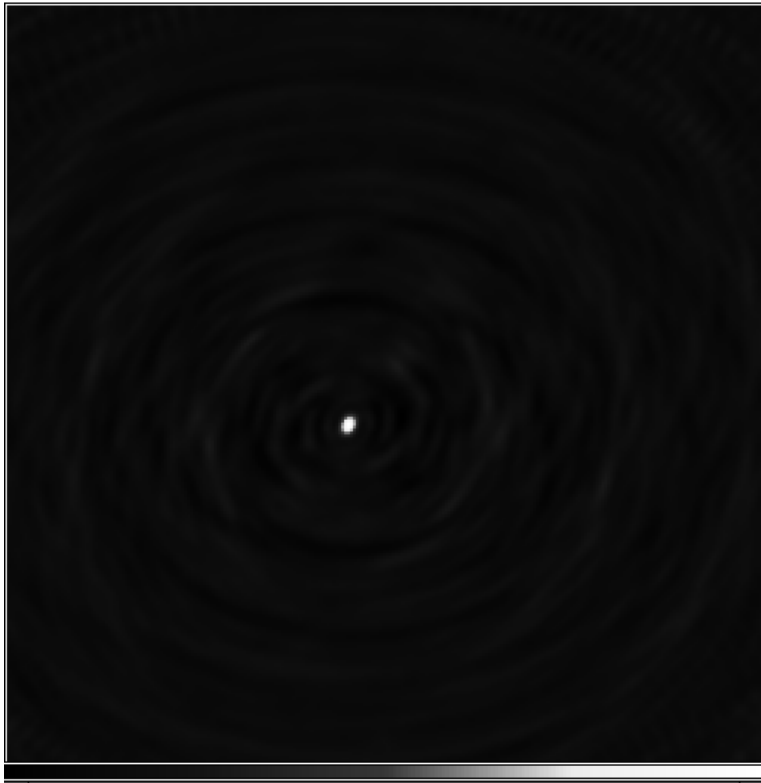
Introduction to interferometric imaging

- The visibility function, $V(u, v)$ is the Fourier transform of the source brightness distribution:
$$V(u, v) = \int I(\mathbf{a}, \mathbf{b}) \exp[-i2\mathbf{p}(\mathbf{a}u + \mathbf{b}v)] d\mathbf{a} d\mathbf{b}$$
- So the idea is to measure V for as many values of u and v as possible & perform an inverse FT:
$$\iint V(u, v) \exp[+i2\mathbf{p}(u\mathbf{a} + v\mathbf{b})] du dv = I_{norm}(\mathbf{a}, \mathbf{b})$$
- But since what we measure is a sampled version of $V(u, v)$, what we actually recover is the so-called "dirty map":

$$\begin{aligned} \iint S(u, v) V(u, v) \exp[+i2\mathbf{p}(u\mathbf{a} + v\mathbf{b})] du dv &= I_{dirty}(\mathbf{a}, \mathbf{b}) \\ &= I_{norm}(\mathbf{a}, \mathbf{b}) * B_{dirty}(\mathbf{a}, \mathbf{b}) \end{aligned}$$

$B_{dirty}(\mathbf{l}, m)$ is the Fourier transform of the sampling distribution, and is known as the dirty-beam.

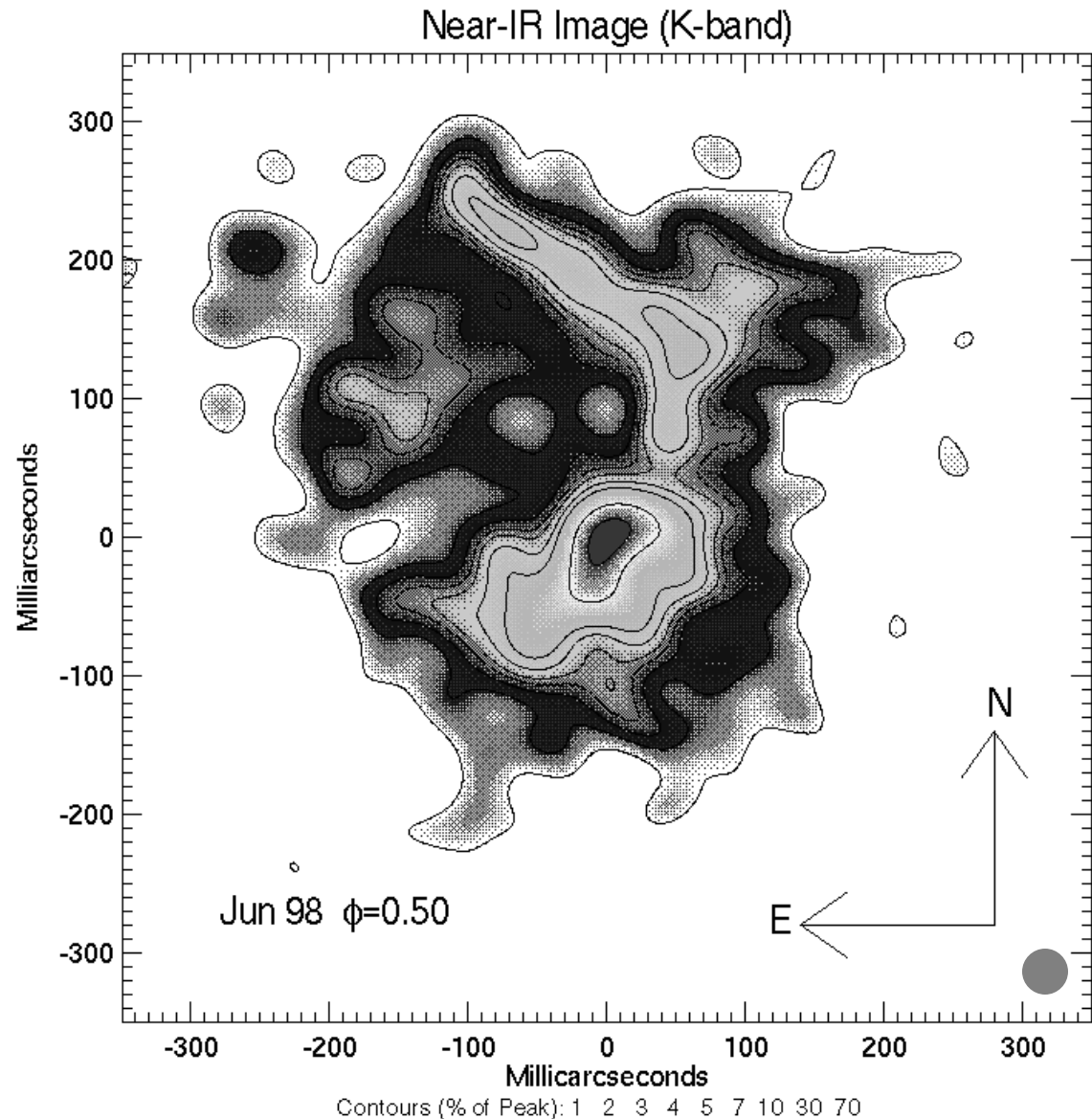
Dirty (and corrected) interferometric images



- Raw interferometric maps generally look awful - but correcting for dirty beam (known as deconvolution- CLEAN, MEM, WIPE) is straightforward.

A real astronomical example

K-band image of IRC+10216. Image courtesy of Peter Tuthill and John Monnier.



Key ideas 8

- Imaging with an interferometer => measuring the visibility function for a wide range of baselines.
- It also => measuring its amplitude and phase.
- The map you get will ONLY contain information corresponding to the baselines you measured.
 - This applies to conventional imaging as well
- There is no such thing as the “correct” image.

Summary

- Interferometers are machines to make fringes.
- The fringe modulation and phase tell you what you are looking at.
- More precisely, these measure the amplitude and phase of the FT of the source brightness distribution.
- A measurement with a given interferometer measures one value of the FT of the source brightness distribution.
- Multiple baselines are obligatory to build up an image.
- Once many visibility measurements are made, an inverse FT delivers a representation of the source that may (or may not) be useful!

